

Notice of References Cited	Application/Control No. 10/591,907		Applicant(s)/Patent Under Reexamination ABT ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-1,136,698 A	04-1915	Mittinger	220/288
*	B	US-1,249,948 A	12-1917	Gruber	228/136
*	C	US-1,332,686 A	03-1920	REYNOLDS HENRY S	285/202
*	D	US-1,591,183 A	07-1926	REYNOLDS HENRY S	16/2.1
*	E	US-2,008,245 A	07-1935	CURTIS DAVID W et al.	285/204
*	F	US-2,018,683 A	10-1935	MEYER PAUL H et al.	228/161
*	G	US-2,031,350 A	02-1936	EVANS LLEWELLYN W	285/204
*	H	US-2,152,919 A	04-1939	RHEEM RICHARD S	285/204
*	I	US-2,316,724 A	04-1943	PIERCE SPERRY	4/288
*	J	US-2,324,791 A	07-1943	FLETCHER MCLOUGHLIN HAROLD et al.	220/3.8
*	K	US-2,327,656 A	04-1943	MEEK JOHN B	285/202
*	L	US-2,842,384 A	07-1958	FOSKETT KENNETH H	285/203
*	M	US-3,061,338 A	10-1962	CLARK EDWARD B	285/202

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,195,943 A	04-1980	Williams, Ronald S.	403/242
*	B	US-4,233,726 A	11-1980	Williams, Ronald S.	29/507
*	C	US-4,334,703 A	06-1982	Arthur et al.	285/222
*	D	US-4,570,747 A	02-1986	Ortyl, George M.	181/243
*	E	US-5,559,308 A	09-1996	Hayashi, Toshiomi	181/265
*	F	US-5,785,119 A	07-1998	Watanabe et al.	165/178
*	G	US-6,517,117 B1	02-2003	Lai, Han-Chin	285/202
*	H	US-2006/0185167 A1	08-2006	Lippa et al.	029/890.038
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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